Search Notes



App	licat	ion/	Con	trol	No.

10/566,705 Examiner

Eunhee Kim

Applicant(s)/Patent under Reexamination

ICHIKAWA ET AL.

Art Unit

2123

SEARCHED					
Class	Subclass	Date	Examiner		
703	22	12/29/2006	EHC		
Above	Updated	7/5/2007	EK		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Conducted inventors search	12/29/2006	EHC	
East text search See attached	12/29/2006	EHC	
Updated the text search	7/5/2007	EK	